Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/790,880	AKIYAMA ET AL.	
Examiner	Art Unit	
Denise Tran	2185	

	SEARCHED		
Class	Subclass	Date	Examiner

INT	INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner	
		:		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
text search (USPAT, USPGPUB,USOCR,EPOAB,JPOAB,D ERWENT, IBM-TDB)	7/31/2007	DT		
711/5,118,170,128-129,104,144; 365/230.03,185.11 (text search only search history)	7/31/2007	DT		
711/103,105, 167; 365/189.01 (text search only search history)	7/31/2007	DT		
inventor name search	7/31/2007	DT		